1 Transport properties of cubic zero-moment ferromagnetic Mn₂Ru_xGa thin ₂ films

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- (Dated: 27 November 2014)

The spin-dependent transport properties of cubic Mn_2Ru_xGa thin-films are studied as a function of the the Ru concentration, x and the substrate induced strain. We find that at Ru concentration $x \approx 0.7$, which shows practically zero magnetization, the spontaneous Hall effect at room temperature reverses sign and the spontaneous Hall angle is maximized. In addition, a small tetragonal distortion, $c/a \sim 2\%$, allows us to tune the compensation of the two Mn sub-lattices to a preferred temperature at, above or below room temperature. Having two handles on the zero moment half magnetic properties of Mn_2Ru_xGa opens up the possibilities for using this new class of material in various spintronic devices. We also present the initial work on magnetoresistive devices based on pseudo-spin-valves with $\mathrm{Mn_2Ru_xGa}$ electrodes.

INTRODUCTION

Cubic ferromagnetic Heusler compounds are a family of magnetic materials that often exhibit higher spin po-11 larization at the Fermi level than binary ferromagnetic 3d ₁₂ alloys¹. Some of the materials are half-metals with a gap 13 in the spin-polarized density of states for one spin band 14 which should make them ideal candidates for spin-valves ₁₅ or MTJs^{2–5}. Since the prediction by van Leuken and de Groot in 1995, of a half-metallic material with two in-17 equivalent magnetic sub-lattices whose moments cancel 18 out⁶, researchers have worked on fabricating such a ma-19 terial. While electronic structure calculations predicted ₂₀ several such compounds⁷⁻⁹, fabrication of such materials had failed^{8,10}. In 2014, Kurt et. al. reported the growth of thin films of Mn₂Ru_xGa (MRG), which was identified 23 as a zero-moment ferrimagnet with high spin polarization ²⁴ and showed evidence of half-metallicity¹¹.

Here we report on the temperature, composition and 26 thickness dependent transport properties of MRG, which are at or near compensation point (0.6 < x < 1.1). Addition of Ru to the cubic Mn₂Ga structure provides both states (12) and electrons (8). Based on the on the empirical Slater-Pauling rules, should result in perfect compensation for Mn₂Ru_{0.5}Ga. However the addition of Ru is likely to change both the shape and position of the Mn bands leading to a more complex behaviour of the magnetic and spin-dependent transport properties. In 35 addition the tetragonal distortion (c/a) can also affect 36 the band structure, hence we also look at strain as a ₃₇ possible control parameter in engineering the MRG fully 38 compensated half metallic system.

EXPERIMENTAL TECHNIQUES

MRG films of thickness 4 nm to 70 nm were grown 41 on MgO (001) substrates by dc-magnetron sputter- 78 The crystal structure of the cubic MRG films with 42 ing at 250 °C substrate temperature and base pressure 79 different thickness and compositions were probed us-

44 films were co-sputtered from a Mn2Ga target and Ru 45 target, and the Ru composition was controlled by keep-46 ing the Mn₂Ga sputtering power fixed while varying that 47 of Ru. The MRG films were capped with a $\sim 2 \, \mathrm{nm} \, \mathrm{Al_2O_3}$ 48 layer to prevent oxidation. The crystal structure and lat-49 tice parameters were determined by $2\theta - \theta$ and reciprocal 50 space map (RSM) scans using a BRUKER D8 diffrac-51 tometer. In order to determine the Ru concentration x, 52 we deposited four samples with varying Mn₂Ga target 53 power along with a Ru film. The density and thickness 54 of the samples were then measured using x-ray reflectiv-55 ity. Based on the measured density and lattice parameters of these 5 control samples, we establish a relation $_{57}$ between the x-ray density and the Ru concentration x58 against which all the samples are calibrated. Magnetiza-59 tion measurements were made using a Quantum Design 60 superconducting quantum interference device (SQUID) 61 magnetometer. The transport measurements were con-62 ducted on unpatterned MRG films in a physical proper-63 ties measurement system (PPMS) for temperatures from 64 10 K to 400 K. The maximum applied magnetic fields, $_{65}$ $\mu_0 H$, for the two systems were 5 T and 14 T respec-66 tively. A summary of sample properties is provided in 67 Table I. We also incorporated the MRG as the hard 68 layer into a pseudo-spin-valve with the structure, MgO/ 69 MRG(15)/Cu(2.8)/[Co(0.2)/Pd(0.6)]₆/Ta(3 nm) in or-70 der to investigate the spin dependent transport. The 71 MRG layer was grown at 250 °C, then cooled down to $_{72}$ room temperature, and was subsequently transferred to ₇₃ a different deposition chamber for the Cu/[Co/Pd] multi-74 layer deposition. Atomic force microscopy measurements ₇₅ of the MRG film showed a roughness of $\sim 0.2 \, \mathrm{nm}$, free of 76 pinholes.

77 III. RESULTS AND DISCUSSION

 $_{43}$ 2×10^{-8} Torr in a Shamrock deposition system. The $_{80}$ ing $2\theta - \theta$ x-ray diffraction (XRD) as shown in Fig.

TABLE I. Summary of sample properties. The temperature at which full compensation occurs, T_{comp} was defined by the temperature where $\partial \rho_{xy}/\partial T$ reaches its maximum.

Ru x	t	c/a - 1	M_s	T_{comp}
	nm	%	$\mu_{ m B}$	K
0.62	70	2.07	-0.09	100-200
0.69	70	1.76	0.03	200 - 300
0.73	70	1.83	0.07	300 - 360
0.77	70	1.92	0.09	> 360
1.09	70	1.82	0.07	> 360
1.12	70	1.84	0.07	387
1.01	34	1.92	-	335
0.98	16	2.24	-	280
1.09	8	2.90	-	214
1.07	4	3.60	-	< 10

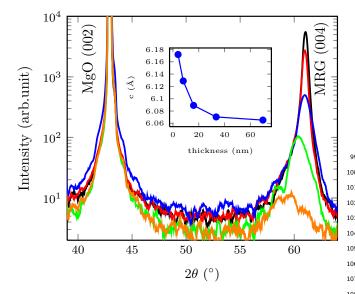


FIG. 1. XRD of thin films of Mn₂Ru_xGa of thickness from 70 nm to 4 nm grown on MgO substrates. Inset shows the dependence of the out-of-plane lattice parameter (c) on the thickness of the film, indicating that the substrate induced strain is increasingly relaxed as the thickness increases.

11. The out-of-plane lattice parameter, c, is between 116 spin polarization. $_{82}$ 0.598 nm and 0.618 nm, depending on the Ru concen- $_{117}$ which is precisely matched to that of the MgO substrate plane distortion (c/a - 1) between 1.8% and 3.6%).

⁹⁶ reduces, until it falls practically to zero (12 kA m⁻¹ or ¹³¹ resistance w.r.t temperature, $\delta R_{XY}/\delta T$, as shown in Fig. ⁹⁷ 0.07 $\mu_{\rm B}$ f.u.⁻¹) at x=0.68 as shown in Fig. 4(a). We ¹³² 5(a), it can be seen that this compensation temperature

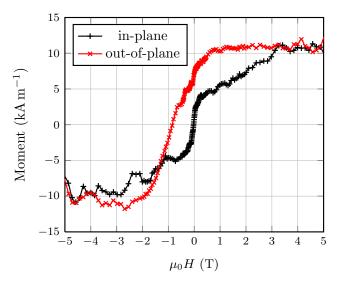


FIG. 2. In-plane and out-of-plane magnetization loops of Mn_2Ru_xGa sample of thickness 70 nm, measured in a SQUID magnetometer at 300 K.

99 the two Mn sub-lattices at room temperature. On fur-100 ther reduction of Ru the magnetization again increases. 101 We denote this as a negative magnetization, coincident 102 with the reversal in sign in the room temperature spon-103 taneous Hall effect (SHE) measurements as shown in Fig. 3(a). From the SHE measurements with varying Ru con-105 tent, we extracted the coercivity, $\mu_0 H_c$, and spontaneous ₁₀₆ Hall angle (SHA) (defined as ρ_H/ρ) (Fig. 4(b)). As the magnetization approaches zero the coercivity clearly di-108 verges (the sample closest to compensation at room tem-109 perature could not be saturated at an applied field of 5 T). The recorded SHA for samples near compensation $(\sim 5\%)$ are about a magnitude larger than those reported 112 for other 3d ferromagnets at room temperature (0.2 to $(0.3\%)^{12}$ and comparable to SHA recorded for amorphous 114 rare earth transition metal alloys 13. A high SHA is in-115 dicative of much lower carrier concentrations and a high

As shown in Fig. 1, the MRG films are increastration and film thickness (insert of Fig. 1). The in- 118 ingly strained as the thickness of the film is reduced. It plane lattice parameter, a, determined from reciprocal 119 has been predicted that the magnetization may depend space maps was found to be 0.596 nm for all samples, 120 strongly on the lattice distortion since this would have an effect on the interaction between neighbouring atoms. $(\sqrt{2}a_0 \,(\mathrm{MgO}) = 0.5956 \,\mathrm{nm})$. This confirms the cubic na- 122 We prepared MRG samples of different thickness from ture of the MRG films with a slight tetragonal out-of- 123 70 nm down to 4 nm and measured their SHE response at different temperatures from 400 K to 4 K in the PPMS. Fig. 2 shows the magnetization measurement at 300 K 125 Fig. 3(b) shows a typical SHE response over the temperof a typical MRG film of 70 nm near compensation of 126 ature range for the sample of 34 nm thickness. It can the magnetic sub-lattices. Clear out-of-plane anisotropy $_{127}$ be seen that the coercivity diverges to $\sim 9\,\mathrm{T}$ at $350\,\mathrm{K}$ with a large coercivity of 1.2 T is evident. A small soft 128 and the sign of the SHE loop reverses at 300 K. This inin-plane component is also clearly visible. As the Ru con- 129 dicates that the compensation temperature lies between centration is reduced from x = 1.09, the magnetization 130 K and 350 K. By plotting the derivative of the Hall 98 can attribute this to the almost perfect compensation of 133 shifts to lower temperatures as the thickness of the MRG

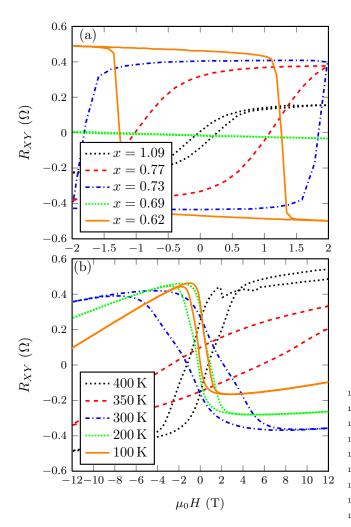


FIG. 3. SHE loops measured of Mn₂Ru_xGa for (a) various Ru compositions (0.6 < x < 1.1) and (b) temperatures between 10 K and 400 K, which illustrates the change of sign of the spontaneous hall coefficient between x = 0.62 and x = 0.73and 300 K and 350 K respectively.

134 is reduced. It is worth noting that the compensation temperature varies with both the Ru content and strain. Since the compensation is achieved by the cancelling out 137 of the moment of the two inequivalent Mn sub-lattices, 168 the slightly different temperature dependence of the two sub-lattices. As with samples with different Ru content, the extracted coercivity and SHA show maximum values 142 near the compensation temperature for each thickness as shown in Fig. 5(b) and (c) respectively.

 $_{150}$ observed MR is however quite low (~ 0.15) even at 4 K $_{181}$ isation that point towards a half metallic state. We also 151 which may be due to two effects: Firstly considering the 182 show that by varying the tetragonal distortion at a par-

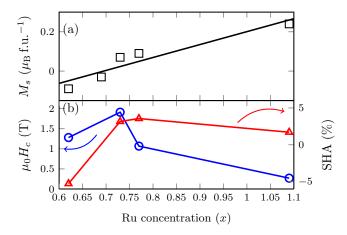


FIG. 4. (a) Extracted magnetization at 300 K (in μ_B f.u.⁻¹), for samples of thickness 70 nm with different Ru composition (0.6 < x < 1.1). The change of sign of the magnetization was established by SHE sign reversal at compensation. (b) Coercive field and spontaneous Hall angle as a function of Ru composition, extracted from SHE measurements carried out at 300 K, for the same MRG samples as in (a).

152 transfer between separate deposition chambers for the 153 MRG and Cu/[Co/Pd] layers, some interfacial contami-154 nation or oxidation of the Mn can be expected. Secondly, based on the results shown for the thickness dependence 156 of the MRG films, as discussed above, we find that the films are increasingly strained as the thickness of the film 158 is reduced. This causes a variation in the spin-dependent 159 transport properties and compensation of the two mag-160 netic sub lattices, compared to the thicker films. Fur-161 thermore we assume that magnetic domains are present in the MRG film as in antiferromagnets; GMR is lost relatively quickly due to domain structuring and imperfect rotation of the magnetisation in the two electrodes, as 165 evidenced by dispersed switching field range as shown in the electronic transport (Fig. 3, and 6).

167 IV. CONCLUSION

We have shown above that the spin-dependent transthis shift in compensation temperature may be due to $_{169}$ port properties of $\rm Mn_2Ru_xGa$ are tuneable with both 170 the Ru concentration x and strain. Recent ab inito 171 calculations¹⁴ while providing some insight into the electronic structure, does not give convincing arguments ex-173 plaining the variation of the transport properties both with varying Ru concentration x and strain. Above we Finally we measured the magnetoresistance (MR) 175 have shown that for a Ru concentration $x \approx 0.7$, which properties of the MRG/Cu/[Co/Pd] samples at different 176 shows practically zero magnetization, the sign of the temperatures from 2 K to 300 K. The MR was measured 177 spontaneous Hall effect is reversed, indicating the reveron unpatterned films in the current-in-plane configura- 178 sal of the majority spin channel. Concurrently the spontion. A MR effect was cleared observed at 2 K, and per- 179 taneous Hall angle is maximised which would imply a resists even at room temperature as shown in Fig. 6. The 180 duction in the carrier concentration and high spin polar-

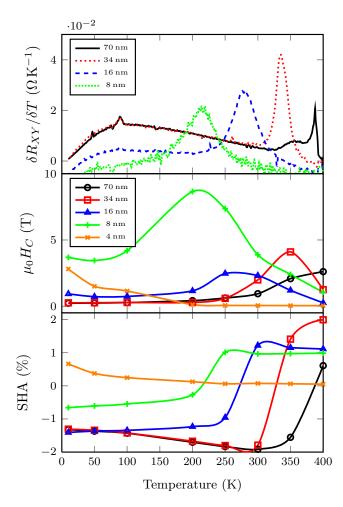
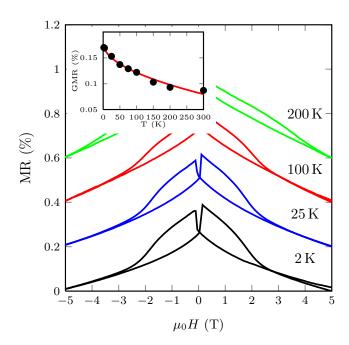


FIG. 5. (a) Variation of compensation temperature with the thickness of MRG film of same Ru concentration, given by the derivative of the resistance w.r.t temperature. The compensation temperature shifts to lower temperatures with decreasing thickness. (b) Extracted coercive field and (c) spontaneous Hall angle as a function of temperature for samples with the same Ru concentration ($x \sim 1.0$) and various thickness from 204 $70 \,\mathrm{nm}$ to $4 \,\mathrm{nm}$.

183 ticular Ru composition, we can tune the compensation of the two Mn sub lattices to be at a relavant temperature regime at above or below room temperature. The initial demonstration of magnetoresistance in pseudo-spin- 212 valves with an MRG electrode indicates that while we 213 are able to observe a MR effect, further understanding of the magnetic domain and micromagnetic structures are $\frac{213}{216}$ 190 necessary for improving device performance.

ACKNOWLEDGEMENTS

This work was supported by Science Foundation Ireland through AMBER, and from grant 13/ERC/I2561. KR acknowledges financial support from the European Community's Seventh Framework Programme IFOX, 227 13 T. W. Kim, S. H. Lim, and R. J. Gambino, Journal of Applied 196 NMP3-LA-2010-246102. DB acknowledges financial sup- 228



MRof \mathbf{a} pseudo $Mn_2Ru_xGa(15)/Cu(2.8)/[Co(0.2)/Pd(0.6)]_6/Ta(3 nm)$ measured at various temperatures. The curves have been offset vertically for clarity. The inset shows the temperature variation of the GMR contribution with a fit to $T^{0.5}$ dependence.

197 port from IRCSET. The research leading to these re-198 sults has received funding from the European Community's Seventh Framework Programme (FP7/2007-2013) under grant agreement n. °312284(CALIPSO). The authors would like to thank H. Kurt, M. Žic and T. Archer 202 for fruitful discussions.

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